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	Document Number							Date	Country	Class	Subclass	Translation	
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Q.WS	1	SensArray Corporation, <u>Process Probe 1840</u> , Data Sheet, 1998
	2	SensArray Corporation, <u>Process probe 1530</u> , Data Sheet, 1998
↓	3	SensArray Corporation, <u>Process Probe 1630</u> , Data Sheet, 1998
	4	SensArray Corporation, <u>1700 Series</u> , Data Sheet, 1994
↓	5	Schott Corporation, <u>BOROFLOAT Borosilicate Float Glass</u> , Data Sheet
	6	Schott Corporation, <u>D 163 Thin Borosilicate Glass</u> , Data Sheet
Examiner Dawette W. Gools		Date Considered 6/8/04
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QWJ	7	Shott Corporation, <u>AF 45 Thin Borosilicate Glass, Data Sheet</u>
	8	SansArray Corporation, <u>Using SensArray Temperature Instrumented Wafers Series 1501, Type R Thermocouples, 6/10/93</u>
4	9	SansArray Corporation, <u>Using SensArray Temperature Instrumented Wafers Series 1501, Type R Thermocouples, 2/5/94</u>

Examiner <i>Daniel J. Goss</i>	Date Considered <i>6/8/04</i>
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Examiner: <u>Ravetta W. Loom</u>	Date Considered, <u>6/8/04</u>
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